

ID	R _{Ds} (ON)(Typ)	VDSS
120A	4.3mΩ	100V
• 100% a	s: witching speed avalanche tested ved dv/dt capability	

Ordering Information

Part Number	Package	Marking	Packing	Qty.
RS100N120T	T0-220	RS100N120T	Tube	50 PCS

Absolute Maximun Ratings Tc= 25° unless otherwise specified

Symbol	Parameter	RS100N120T	Units
VDSS	Drain-to-Source Voltage	100	V
ID	Continuous Drain Current TC=25℃	120	
ID	Continuous Drain Current TC=100℃	80	А
IDM	Pulsed Drain Current	480	
PD	Power Dissipation	178	W
VGS	Gate- to- Source Voltage	±20	V
EAS	Single Pulse Avalanche Engergy L = 3.0mH,VDS = 50V, RG = 25Ω, Tj = 25℃	486	mJ
	Maximum Temperature for Soldering		
TL TPKG	Leads at 0.063in(1.6mm)from Case for 10 seconds Package Body for 10 seconds	300 260	°C
TJ and TSTG	Operating Junction and Storage Temperature Range	-55 to 150	

* Drain Current Limited by Maximum Junction Temperature

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" Table may cause permanent damage to the device.



Thermal Resistance

Symbol	Parameter	RS100N120T	Units	Test Conditions
RØJC	Junction-to-Case	0.7	°C / W	Drain lead soldered to water cooled heatsink, PD adjusted for a peak junction temperature of + 1 5 0 $^{\circ}$ C
RθJA	Junction-to- Ambient	46		1 cubic foot chamber,free air.

OFF Characteristics TJ= 25° C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BVDSS	Drain- to- source Breakdown Voltage	100			V	VGS=0V,ID=250μ Α
IDSS	Drain- to- Source Leakage Current			1	μA	VDS=80V,VGS=0 V
	Gate- to- Source Forward Leakage			100	- 4	VGS=20V ,VDS=0 V
IGSS	Gate- to- Source Reverse Leakage			-100	nA	VGS=-20V ,VDS= 0V

ON Characteristics TJ=25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
RDS(on)	Static Drain- to- Source On- Resistance		4.3	5.3	mΩ	VGS=10V,ID=20A
			5.5	7.5	mΩ	VGS=4.5V,ID=10 A
VGS(TH)	Gate Threshold Voltage	2	3	4	V	VGS=VDS,ID=25 0μA

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
td(ON)	Turn- on Delay Time		18		- nS	
trise	Rise Time		23			VDS=50V ID=20A
td(OFF)	Turn- OFF Delay Time		37			RG=3Ω VGS=10V
tfall	Fall Time		16			



Dynamic Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Ciss	Input Capacitance		4100			VGS= 0V
Coss	Output Capacitance		590		pF	VDS=50V
Crss	Reverse Transfer Capacitance		20			f=1MHz
Qg	Total Gate Charge		69			VDS= 50V
Qgs	Gate- to- Source Charge		24		nC	ID=20A
Qgd	Gate-to-Drain(" Miller") Charge		19			VGS=10V

Source- Drain Diode Characteristics

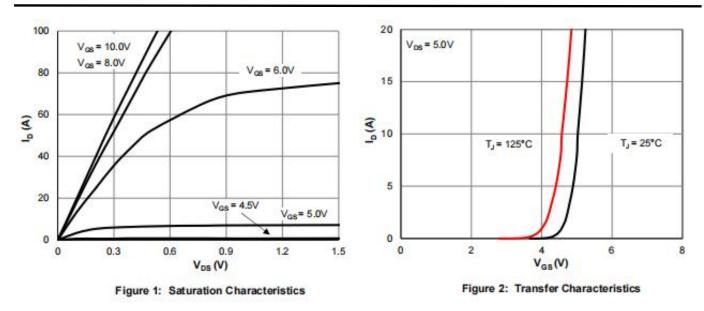
Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions	
IS	Continuous Source Current			120	А	Integral pn- diode	
ISM	Maximum Pulsed Current			480	А	in MOSFET	
VSD	Diode Forward Voltage			1.0	V	IS=20A,VGS=0V	
trr	Reverse Recovery Time		64		nS	VGS=0V	
Qrr	Reverse Recovery Charge		126		nC	IS=20A di/dt=100A/μs	

Notes:

* 1. Repetitive rating, pulse width limited by maximum junction temperature.

* 2. Pulse Test: Pulse width \leq 300µs, Duty Cycle \leq 1%

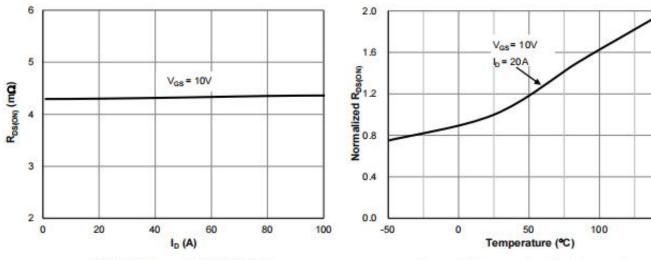
Typical Feature Curve

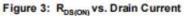


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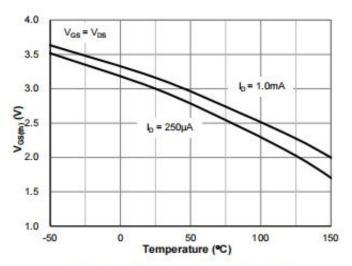


150

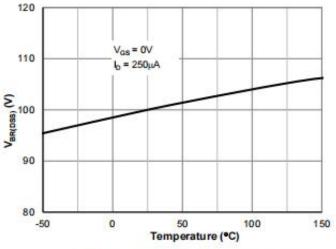




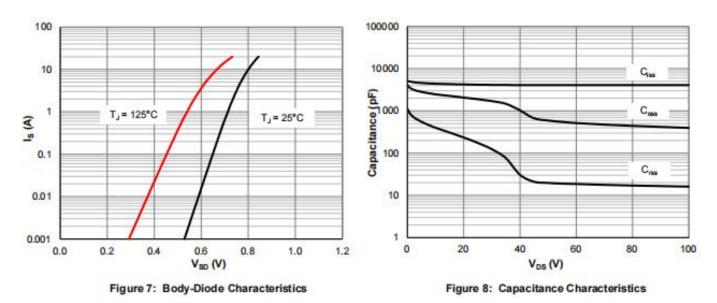








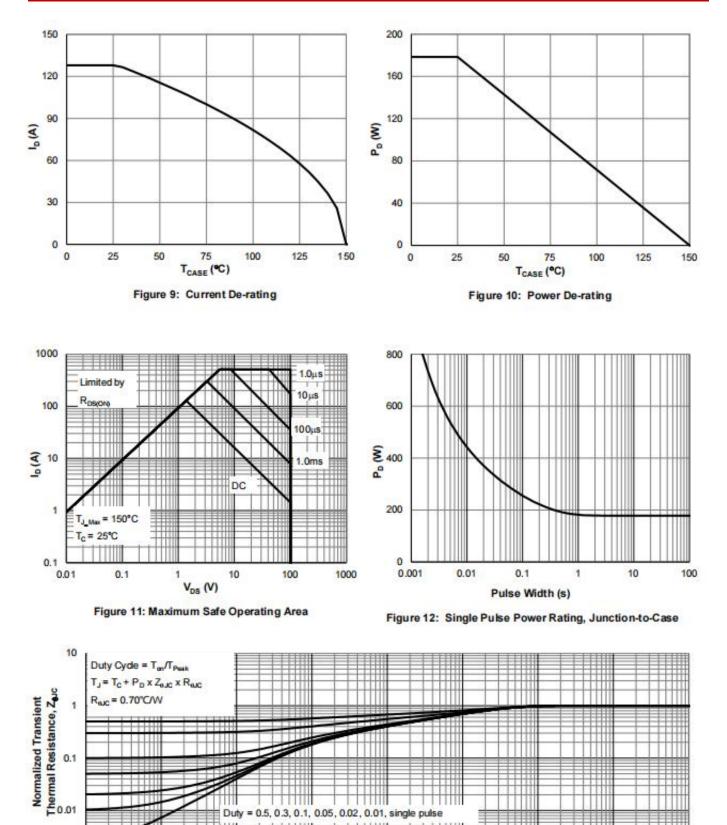




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0.001

0.000001

0.00001

0.001

0.01

Pulse Width (s) Figure 13: Normalized Maximum Transient Thermal Impedance

0.1

1

HH.

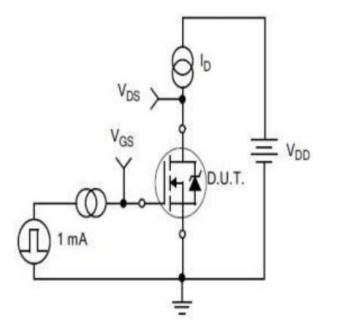
0.0001

10

100



Test ircuits and Waveforms



VGS(TH)

VDS

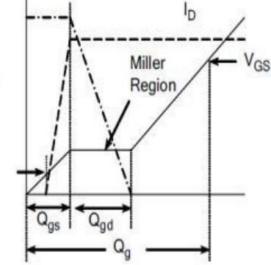


Figure A. Gate Charge Test Circuit

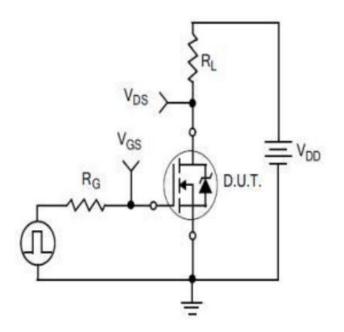


Figure C. Resistive Switching Test Circuit

Figure B. Gate Charge Waveform

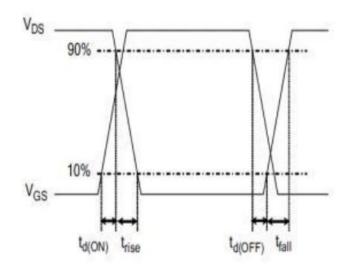
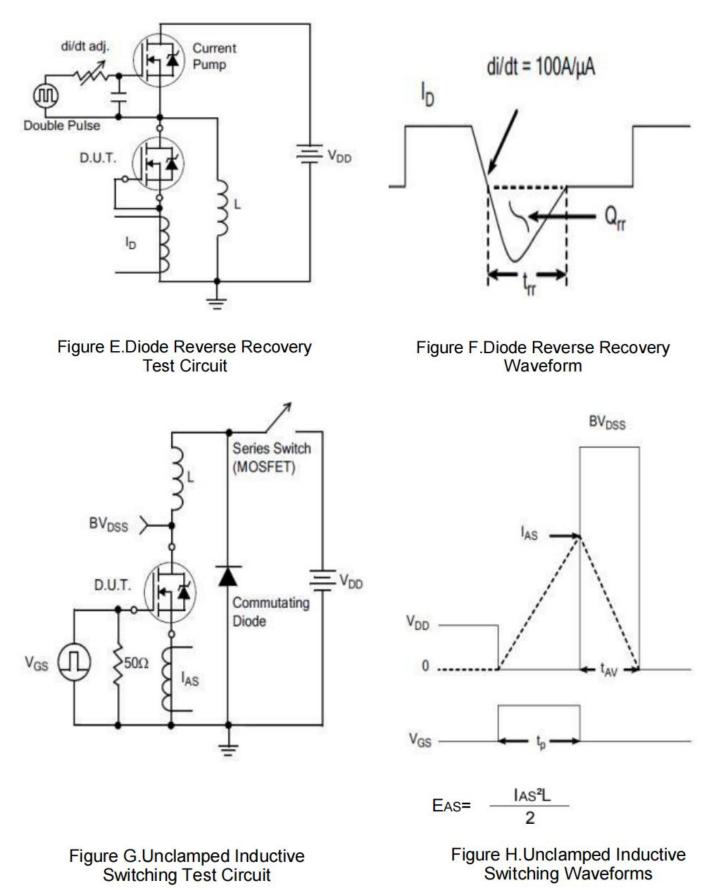


Figure D. Resistive Switching Waveforms

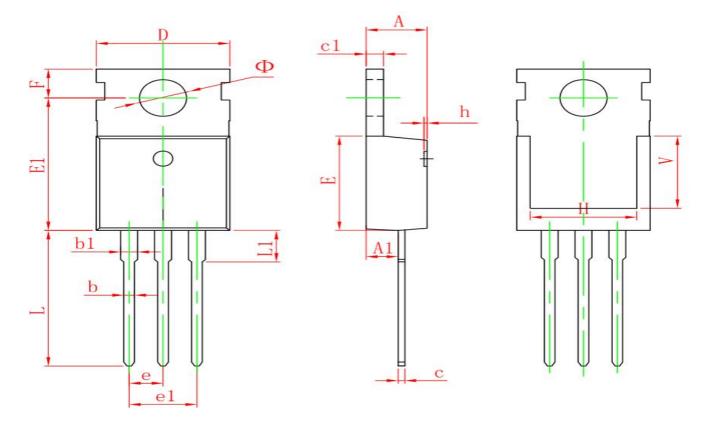


Test ircuits and Waveforms





Package outline drawing(TO-220 Unit: mm)



Symbol	Dimensions	In Millimeters	Dimension	s in inches
Symbol	Min.	Max.	Min.	Max.
A	4.400	4.600	0.173	0.181
A1	2.250	2.550	0.089	0.100
b	0.710	0.910	0.028	0.036
b1	1.170	1.370	0.046	0.054
С	0.330	0.650	0.013	0.026
c1	1.200	1.400	0.047	0.055
D	9.910	10.250	0.390	0.404
E	8.950	9.750	0.352	0.384
E1	12.650	13.050	0.498	0.514
е	2.540	TYP.	0.100) TYP.
e1	4.980	5.180	0.196	0.204
F	2.650	2.950	0.104	0.116
Н	7.900	8.100	0.311	0.319
h	0.000	0.300	0.000	0.012
L	12.900	13.400	0.508	0.528
L1	2.850	3.250	0.112	0.128
V	6.900	REF.	0.276	REF.
Ф	3.400	3.800	0.134	0.150



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